

# Search Notes



Application/Control No.

10/694,517

Examiner

Hiep Nguyen

Applicant(s)/Patent under Reexamination

IVANOV ET AL.

Art Unit

2816

## SEARCHED

Class	Subclass	Date	Examiner
327	63	07.20.04	Ha
	65	↓	↓
	66		
	67		
	70		
	68		
	77		
	57	↓	↓
All searches updated		03.08.05	Ha

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
327	63	03.08.05	Ha
	65	↓	↓
	67	↓	↓

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST	07.20.04	Ha